

Search Notes

Application/Control No.

10/812,197

Examiner

Patrick J. Lee

Applicant(s)/Patent under
Reexamination

DUDEK ET AL.

Art Unit

2878

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|-------------------------------|--------------------------|----------|
| 250 | 208.1, 214A, 214.1, 552 | 11/15/2006 11/20/2006 | PL |
| 257 | 222, 225 | ↓ | PL |
| 257 | 257-258 | ↓ | PL |
| 257 | 290-291 | ↓ | PL |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|------|----------|
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|--|------------|------|
| East (see attached) - USPAT, US-PGPUB, EPO, JPO, DERWENT | 11/15/2006 | PL |
| East (see attached) - USPAT, US-PGPUB, EPO, JPO, DERWENT | 11/20/2006 | PL |
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